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Understanding important features of deep learning models for segmentation of high-resolution transmission electron microscopy images

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Cutting edge deep learning techniques allow for image segmentation with great speed and accuracy. However, application to problems in materials science is often difficult since these complex models may have difficultly learning meaningful image features that would enable extension to new datasets. In situ electron microscopy provides a clear platform for utilizing automated image analysis. In this work, we consider the case of studying coarsening dynamics in supported nanoparticles, which is important for understanding, for example, the degradation of industrial catalysts. By systematically studying dataset preparation, neural network architecture, and accuracy evaluation, we describe important considerations in applying deep learning to physical applications, where generalizable and convincing models are required. With a focus on unique challenges that arise in high-resolution images, we propose methods for optimizing performance of image segmentation using convolutional neural networks, critically examining the application of complex deep learning models in favor of motivating intentional process design.

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INTRODUCTION

In situ and operando experimental techniques, where dynamic process can be observed with high temporal and spatial resolution, have allowed scientists to observe chemical reactions, interfacial phenomena, and mass transport processes to give not only a better understanding of the physics of materials phenomena, but also a view into how materials react under the conditions in which they are designed to perform^{1,2}. As the use of in situ techniques continues to expand, and technology to enable these experiments continues to develop, we are faced with the fact that more data can be produced than can be feasibly analyzed by traditional methods^{3,4}. This is particularly true for in situ electron microscopy experiments, where high-resolution images are captured at very high frame rates. In practice, hundreds of images can be captured per second. However, many experimental analyses consider less than one frame per second, or even one frame for every several minutes⁵. Methods for fast and efficient processing of high-resolution imaging data will allow for not only full utilization of existing and developing technologies, but also for producing results with more statistical insight based on the sheer volume of data being analyzed.

Simultaneously, the field of computer vision provides well understood tools for image processing, edge detection, and blob localization that are helpful for moving from raw image data to quantifiable material properties. These techniques are easy to apply in many common computer programming languages and libraries. However, more recent research highlights the processing speed and accuracy of results obtained through the use of machine learning^{6,7}. Previously, a combination of traditional image processing and advanced statistical analysis has be shown to successfully segment medical images^{8,9}. Deep learning—generally using multilayer neural network models—expands on other machine learning techniques by using complex connections between learned parameters, and the addition of nonlinear activation functions, to achieve the ability to approximate nearly any type of function¹⁰. With regards to image segmentation and classification, the use of convolutional neural networks (CNNs), in which high-dimensional learned kernels are applied across grouped image pixels, is widespread. CNNs provide the benefit that their learned features are translationally equivariant, meaning that image features can be recognized regardless of their position in the image. This makes such models useful for processing images with multiple similar features, and robust against variation in position or imaging conditions¹¹. Additionally, the feature richness of high-dimensional convolutional filters and the large number of connections between hidden layers in a neural network allows for the learning of features that, conventionally, are too complex to represent, and that make intuitive interpretation difficult. Much of the literature studying CNNs focuses on high-accuracy segmentation/classification of large, complex, multiclass image datasets or upon improving data guality through super-resolution inference, rather than quantitative analysis of high-resolution images¹². Though conventionally used to specify atomic-resolution imaging in the field of electron microscopy, in this work we use the term high-resolution to refer to the pixel resolution of the microscope camera. While additional memory requirements alone make processing of high-resolution images difficult, the scale of features and possible level of precision also changes as a function of image resolution. Most importantly, for the simple case of particle edge detection, the boundary between classes in a high-resolution image may spread across several pixels, making segmentation difficult even by hand. Generally, literature studies of CNNs for image classification are used for many-class classification with coarse-if any-object localization, while in the field of electron microscopy fewer individual object classes exist in a single image, yet precise positioning is required.

Though, it seems, the tools for rapid segmentation of highresolution imaging data exist, several points of concern regarding

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the use of deep learning must be acknowledged. First, while the ease of implementation using common programming tools enables extension of methods to new applications by nonexperts, the complexity and still-developing fundamental understanding of deep learning can lead to misinterpretation of results and poor reproducibility^{13,14}. Moreover, models can be prone to overfitting -memorizing the data rather than learning important features from limited training examples—which can go unnoticed without careful error analysis^{15,16}. Overfitting occurs when a model has enough parameters that an unrealistically complex function can be fit to match every point in a dataset. Thus, a model which accurately labels data by overfitting will likely fail when shown new data, since its complex function does not describe the true variation in the data. Therefore, an overfitted model isn't useful for future work. Finally, the high dimensionality of data at intermediate layers of a neural network combined with the compound connections between hidden layers makes representation, and therefore understanding, of learned features impossible without including more assumptions into the analysis. These challengesspecifically representation and visualization of CNN models-are areas of active research^{17,18}

We focus on semantic segmentation of environmental transmission electron microscopy (ETEM) images of supported gold nanoparticles¹⁹⁻²². Ensembles of supported nanoparticles are important for industrial catalysis, deriving their exceptional catalytic activity from surface energy resulting from the high amount of under-coordinated surface atoms relative to the particle's bulk volume. On a thermodynamic basis, the high surface energy that allows for effective catalysis also provides a driving force for nanoparticle sintering through a variety of mechanisms^{23,24}. Theory exists to describe the mean-field process of Ostwald ripening and basics of nanoparticle coalescence, yet local effects and interparticle interactions cause deviations from our theoretical understanding. Obtaining precise sizes and locations of nanoparticles as a function of space and time is imperative to describing nanostructural evolution, and developing a physical understanding of the processes leading to catalyst degradation by particle growth. Thus, our high-contrast images of supported gold nanoparticles provide a simple, yet important, case study for developing efficient methods of image segmentation so that individual particle-scale changes can be studied.

Building on previous work on image segmentation, automated analysis, and merging deep learning within the field of materials science, we study a variety of CNN architectures to define the most important aspects for the practical application of deep learning to our task. We discuss how image resolution affects segmentation accuracy, and the role of regularization and preprocessing in controlling model variance. Further, we investigate how image features are learned, so that model architectures can be better designed depending on the task at hand. By using a simpler approach to semantic segmentation, in contrast to poorly understood and highly complex techniques, we intend to show that conventional tools can be utilized to construct models that are both accurate and extensible.

RESULTS

High-resolution image segmentation

Particularly in the field of medical imaging, studies regarding similar image segmentation tasks have been published^{25,26}. In these cases, an encoder–decoder, or 'hourglass'-type CNN architecture was found to be well suited to segmentation tasks, where spatial positions of features are key. With this approach, successively deeper convolutional/max-pooling layer pairs (added to decrease spatial resolution while simultaneously increasing feature richness) are combined with up-sampling convolutional layers that aim to rescale the image back to a higher resolution,

while decreasing the feature dimension of the image source^{21,27,28}. In many cases, however, these tasks are used to identify whether a specific feature or object is present or absent, not to measure the size of such features with any level of precision. Correspondingly, our tests show that this network structure successfully identifies nanoparticle pixels in our images with 512×512 resolution, yet consistently misses the centers of the largest particles (Supplementary Fig. 1).

To improve the segmentation performance, we moved to a more complex architecture inspired by the UNet²⁹. This model, rather than increasing kernel size with the goal of expanding the receptive field, uses skip connections to tie activations in the encoding stage to feature maps in the decoding stage, in order to improve feature localization. Skip connections work by concatenating encoded and decoded images of the same resolution followed by a single convolutional layer and activation function to relate unique aspects of both images (see visual representation in Supplementary Fig. 2). This improves upon the similar hourglass architecture by maintaining local environments from the original image to map features to the output. Results using the UNet-type architecture on our image set show that the model is able to consistently recognize both large and small particles, and that it is robust against varied imaging conditions and datasets (Fig. 1 shows results on images from experiments not represented in the training set).

Using our earlier approach, we trained the same UNet on higher resolution images $(1024 \times 1024 \text{ pixels})$, however, as seen in Fig. 2, this network was not able to accurately label pixels at nanoparticle edges, showing instead a blur of uncertainty at the edges. Moreover, we noticed that training the same model on the same data more than once would produce different results: while in some cases training produced image segmentation with wide edge variation, other training instances gave segmentation results with nearly perfectly identified particles, with little to no variation at particle edges. These results likely signal overfitting of the dataset, with the model "memorizing" the noise rather than actual features, as raw activation maps (Fig. 3) show that in fact no features of particles are learned by the model and instead only noise patterns in the background areas are recognized. This model, therefore, produces a very accurate particle measurement on the training dataset, but would not generalize to data from other experiments or with particles of different sizes (i.e., the same dataset with a different magnification). This is further highlighted by the instability of the model with respect to the length of training time.

Rather than solely increasing the width and depth of the model to improve performance and stability (we used a four-step UNettype architecture for 1024×1024 images, as depicted in Supplementary Fig. 2), the greatest improvement in model performance comes through understanding where the model fails when increasing image resolution. Fifteen unique UNet models were tested with architectural modifications inspired by the errors observed in our tests. These modifications, and the motivation for each, are described in Table 1. The effect of learning rate on model performance was also investigated empirically in order to determine how to best sample the loss landscape, but in this regard, we found that a learning rate of 0.0001 is practical and effective for all deep models on our dataset.

Results from all fifteen models are shown in Supplementary Fig. 3. Our initial gauge of performance is qualitatively based on the ability to detect particles of varying size, sensitivity to noise and illumination variation in the raw image, and the sharpness of the activation cutoff at particle edges. Based on these criteria, best performance is seen in models with batch normalization only and batch normalization combined with extra convolutional layers (Fig. 4, Norm and TwoConv_Norm, respectively). From this, it appears that batch normalization is the most important factor for learning particle features from 1024×1024 images. Visual

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Fig. 1 UNet architecture improves particle segmentation compared to encoder-decoder architecture. Segmentation results for UNet-type architecture on 512×512 resolution images. **a** Raw output from the model overlaid on the raw image; notice the sharp activation cutoff at the particle edges. **b** Threshold applied to image to show final segmentation result. Yellow arrows indicate small particles that were successfully recognized. Scale bar represents 50 nm.



Fig. 2 Application of the UNet architecture in high-resolution images yields uncertainty at particle edges. Using the same UNet architecture but increasing image resolution makes it more difficult for the model to localize edge features. Scale bar represents 50 nm.

inspection of Fig. 4 also shows that, in general, blurred images detect edges further toward the interior of the nanoparticle, and models with an additional convolutional layer (and no blurring) are virtually indistinguishable from those with a single up-sampling convolution. More importantly, only models without blur are able to consistently and accurately label small, low-contrast particles.

Aside from applying batch normalization, we find that the only way to achieve significant segmentation improvement on high-resolution images is to increase the size of the convolutional kernel, here from 3×3 pixels to 7×7 (Supplementary Fig. 4). However, this greatly increases the number of trainable parameters and training time for the model.

To briefly summarize the practical implications of our findings, continual batch normalization through successive convolutional layers has a significant positive effect on the performance. For our dataset, increasing network depth does not appear to increase the performance of the CNN. A slow learning rate produces the best results and most stable models, while preprocessing training images with Gaussian blur seems to increase the risk of overfitting.

Evaluating detection accuracy

Variation in the color scale at particle edges, as seen Fig. 2, led us to believe that our particle measurement would vary greatly as a

function of the chosen softmax-activation threshold. Intensity line profiles, as shown in Fig. 5, are helpful in illustrating this edge variation for two models compared to the intensity of the raw image. These plots check how two different models perform in comparison with the edge contrast in the raw image. As the intensity approaches 1, both models show a slope toward the particle center showing the extent of uncertainty in classification at the particle-support interface. Supplemental Figure 5 collects precision and recall scores for the batch-normalized CNN as a function of threshold value, and the amount of Gaussian blur applied compared to a set of 50 validation set labels. Here, high precision means that the model produces few false positives (pixels labeled as particle that actually correspond to background), while recall measures the proportion of particle pixels that were successfully identified by the model (see individual plots in Supplemental Fig. 4). Based on these results, we could expect that the normalized models with no applied blur, and blur ($\sigma = 1$) are stable with respect to precision and recall at a particle activation threshold values <0.7. The model trained on blurred images with $\sigma = 2$, shows similar performance over a smaller range of stable thresholds. For our case of binary classification of an unbalanced dataset, where recognizing particles pixels is more important than recognizing background, recall is likely the most important measure for determining a threshold for use in practice. While we see convergence with maximum precision for the model without blur around a threshold of 0.7, we realize that our empirically selected value of 0.4 gives better recall with essentially the same precision as compared to thresholding at 0.7.

Learning features with a simpler model

Training stability and model overfitting pose large risk for image segmentation CNNs that are to be used and continually developed on varied datasets. While performance often increases with the addition of tunable model parameters, achieving training convergence and interpretation of the model's output become increasingly difficult. With this in mind, we developed a significantly pared down CNN, with a single convolutional layer consisting of a single learnable filter followed by softmax activation on our training data that produced the segmentation shown in Fig. 6b. The benefit of such an architecture is that, since the dimensionality of the kernel is the same as that of the image, we can easily visualize the learned weights (Fig. 6a). Previous work confirms that edges and other spatially evident image features are generally learned in the early convolutional layers of a CNN³⁰. Repeating the same method with another kernel size, this time 7×7 pixels rather than the initial 9×9 , produces a similar filter, showing that the results are not an artifact of the feature scale.



Fig. 3 An overfitting network learns no features of nanoparticles, but recognizes background noise. a The CNN output for a given image. b, c The raw activation values for layers detecting background and particles, respectively. The softmax function combines these activation maps to produce (a). The scale bar in a represents 50 nm and applies for all three images.

Such a single-layer model with logistic activation can be compared, in practice, to a sparse convolutional autoencoder, or even the application of a linear support vector machine for logistic regression³¹.

While this model is useful for illustrating the power of simpler machine learning methods, minimal changes are needed to extend this idea to a model that provides usable, practical segmentation. Using one convolutional layer, now with 32 filters, followed by a second, 1×1 convolutional layer to combine the features into a segmented image, we test a shallow but wide CNN architecture. Again, aside from the convolutional layer used to combine the extracted features, filters from this shallow network can be visualized to see what features are being learned from the data. The F1 score of this simpler model (Fig. 7a, blue line) is comparable to the performance of the most accurate deep network described above (batch normalization with no applied blur-red line). These results illustrate that a model with significantly fewer parameters and guicker training time can still produce a usable segmentation. Indeed, as shown in Fig. 7b, the edges detected by the simpler CNN are in many cases closer to the actual particle edge than those of the deep model; in this light, the decrease F1 score in Fig. 7a is likely due to the high rate of false positives in the simple model. In practice any false positive clusters are significantly smaller than true nanoparticles, so filtering by size to further increase accuracy is possible. Our results suggest that shallow, wide CNNs have enough expressive power to segment high-resolution image data³².

DISCUSSION

Our initial experiments revealed the importance of a segmentation model developing an understanding of a pixel's broader environment, rather than simply identifying features based on intensity or distance to an edge. The fact that the simple, hourglass-style CNNs cannot identify the interior of particle as such, can be attributed to an inability of the CNN to learn similar features with different size scales; we suspect that, in an edgedetecting model, the lack of variation in the interior of a particle appears similar to the in the background leading to improper classification. This clearly indicates the importance of semantic understanding, in which the local environment is considered in detail. Indeed, increasing the receptive field (kernel size) of the network to incorporate more local information improves detection accuracy, yet this approach drastically increases the number of learnable parameters in the CNN and the training time required for convergence. This is reinforced in seeing the improved performance of the UNet compared to the hourglass CNN. Maxpooling after each convolutional layer effectively increases the receptive field of the next convolutional layer; concatenating encoding and decoding activations serves as a comparison of the same features over a variety of length scales.

While segmentation of 512×512 pixel images is possible and seemingly accurate, higher measurement precision can be achieved by utilizing higher resolution cameras available on most modern electron microscopes. For an image with a fixed side length, increasing pixel resolution decreases the relative size of each pixel. Decreasing the pixel size increases the possible measurement precision, and therefore, high-resolution images are needed to provide both accurate, and consistent particle measurements. Along these lines, the error introduced by mislabeling a single pixel decreases as pixel density (image resolution) increases. It's important to note that though the accuracy of manual particle measurements from images with different resolutions likely changes very little (assuming accuracy is mainly dependent on the care taken by the person making measurements), changes in resolution, particularly around particle edges, can greatly influence automated labeling performance since edge contrast decreases as interfaces are spread across multiple pixels. Thus, a unique challenge for high-resolution image segmentation is developing a model that is able to recognize interface pixels, which appear fundamentally different from the interior of a nanoparticle, as contributing to the particle and not the background. To account for increased complexity of the features in higher resolution images, we expanded our network architecture both in depth and width with the idea that a larger number of parameters would increase the expressive power of the model. In fact, this deeper and wider model (seen in Fig. 2) showed little increase in performance compared to the one for low-resolution images. A more effective approach would match the strengths of the segmentation models to the features of the data. For our case of relatively simple images, increasing the complexity of the model alone does not achieve this goal.

Our findings show that regularization, in this case by batch normalization, is vital to accurate labeling of an image. When training from scratch, i.e., without pretrained weights, it has been shown that the loss function is smoother and model convergence is better when using batch normalization, which may have a significant effect on higher resolution images due to the combinations of strong noise and lack of visually discriminative features on the scale of the receptive field³³. Properly pairing regularization, in attempt to maintain the distribution of intensity values in the image, with an activation function suited to allowing such a distribution is essential. As such, the dying rectified linear unit (ReLU) problem, where CNN outputs with a negative value are pushed to zero, removing a significant portion of the actual distribution of the data, causes loss of information and difficult convergence^{10,34}. Our use of ReLU activation functions essentially produces output values in the range $(0,\infty)$, which presents a risk of activation divergence, and can be mitigated by normalization in successive convolutional layers before the final softmax activation. Leaky ReLU allows activations on the range $(-\infty,\infty)$, and the small activation for negative pixel values combined with batch

Table 1. Summary of difficulties in segmenting high-resolution images.		
Problem	Modification	Motivation
Particle features not recognized	Additional convolutional layer at each up- sampling step	Successive convolutional layers work to relate spatial and feature dimensions, not just concatenate ^{29,30}
Unclear boundaries at particle edges	Preprocessing with Gaussian blur	Noise makes actual features difficult to detect, reducing frequency of variation makes physical features apparent
No activation in particle output layer	Apply leaky ReLU activation	Small activations are pushed towards 0 ("dying ReLU problem") ^{10,31}
Large variation in raw activation values	Add batch normalization after each convolutional layer	Regularize model variance at each step to maintain original intensity distribution ³²
Each potential problem is described, along with a data-driven approach to a solution.		



Fig. 4 Otsu threshold contours of six CNN models overlaid on a section of a test image. The model with batch normalization only consistently provides the most accurate segmentation. Each colored contour refers to a different model output: red—TwoConv_Blur1, blue—TwoConvNorm_Blur1, green—Norm_Blur1, purple—Two-Conv, orange—TwoConv_Norm, and yellow—Norm.

normalization works to avoid increasing variance with the number of convolutional layers. In practice, we find that using Leak ReLU activation solves the problem seen in Fig. 3, where no activation is seen for the particle class.

These results suggest that, for a common segmentation task, regularization is more effective than the depth or complexity of a CNN. This is easily justified, considering that the proper classification of boundary pixels, spread across several pixels in high-resolution images, requires the sematic information stored in the total local intensity distribution that is lost as the variance of the intensity histogram increases.

As shown in Fig. 7, the choice of an activation threshold for identifying nanoparticles can greatly influence the labeling error. The steep slope of the softmax-activation function used in the final CNN layer works to force activation values toward 0 or 1-in an ideal case the number of pixels with activation values between these values would be minimal. Our experience shows that the Otsu threshold, which separates the intensity histogram such that the intraclass variance is minimized, is a practical choice for segmenting our data³⁵. This makes sense, since, qualitatively, CNN output shows a large peak close to 0 activation representing the background with nearly all pixels with higher activation values corresponding to particles. However, it can be shown mathematically that the calculated Otsu threshold may mislabel the class with a wider intensity distribution³⁶. Therefore, thresholding datasets with a lower signal-to-noise ratio would likely be more difficult. In these cases, it is imperative that a large dataset—which is representative of the data in question—is used for training, as choosing low threshold values, even when they produce usable results, makes it difficult to recognize overfitting.

An effective machine learning model requires a balance between the number of learnable parameters, the complexity of a model, and the amount of training data available in order to prevent overfitting and ensure deep $\bar{\text{learning efficiency}}^{32,37}.$ In an efficient model, a vast majority of the weights are used, and vital to the output. In practice though, deep networks generally have some amount of redundant or trivial weights³⁸. In addition to efficiency, several issues have come to light regarding the use of deep learning for physical tasks that require an interpretable and explainable model, as this often leads to better reproducibility and results that generalize well^{18,37}. Even for computer vision tasks, where feature recognition doesn't necessarily give physical insight, an interpretable model is valuable so that sources of error can be understood when applied to datasets consisting of thousands of images, each of which cannot feasibly be checked for accuracy. Our main goal in employing a single-layer neural network was to provide a method for visualizing learned kernels that show the most important features of an image for binary classification. The visualization of our trained kernel (Fig. 6a) can be interpreted in two ways. First, we can conceive that the algorithm is learning vertical and horizontal lines (dark lines), potentially similar to basic Gabor filters for edge detectionthough it is missing the characteristic oscillatory componentcombined with some amount of radially symmetric blur (light gray). Alternatively, we can envision that the horizontal/vertical lines could be an artifact of the electron camera or data augmentation method meaning that the learned filter represents an intensity spread similar to a Laplacian of Gaussian (LoG) filter, which is used to detect blobs by highlighting image intensity contours. As a simple test of our supposition, Supplementary Fig. 6 shows that a sum of a horizonal Gabor filter, vertical Gabor filter, and Gaussian filter qualitatively produces a pattern similar to our learned kernel

As mentioned, increasing the width of a shallow network (in this case from 1 to 32 filters) is enough to make a simple model more usable. Though 32 filters (visualized in Supplementary Fig. 7) may be too many filters to easily compare for visually extracting useful information, it is possible to see a general trend: filters are learning faint curved edges. Moreover, taking the mean of all 32 filters (Supplementary Fig. 8) shows a similar pattern as Fig. 6a with slight rotation. Further analysis of the set of 32 filters would require regularization of the entire set of weights to allow for more direct comparison; however, it is possible to imagine a case where, with a properly tuned receptive field in the convolutional layer, more subtle image features than hard lines could be revealed through visualizing a learned kernel. Based on these results, we expect that designing a shallower neural network that retains the local semantics learned in an encoder–decoder or UNet



Fig. 5 Visualizing intensity profiles for specific particles shows segmentation differences between models. Intensity profiles for selected particles in a training image. Line scans show the intensity variation for each particle in the raw image (solid), network with batch normalization (dotted), and network with batch normalization and extra convolutional layers (dashed).

architecture would make a generalizable model for particle segmentation more realistic.

In summary, we have systematically tested several design aspects of CNNs with the goal of evaluating deep learning as tool for segmentation high-resolution ETEM images. With proper dataset preparation and continual regularization, standard CNN architectures can easily be adapted to our application. While overfitting, class imbalance, and data availability are overarching

np 6



Fig. 6 A one-layer CNN produces a viable segmentation, and the learned kernel is interpretable as an image. The kernel (a) learned by a single-layer CNN, and the segmentation it produces (b, after softmax activation).



Fig. 7 An expansion of the simplified CNN produces a segmentation with comparable accuracy to the output of a deep CNN. a Mean *F*1 score for UNet (only modified by adding batch normalization) and simple one-layer CNN architectures as a function of Softmax threshold cutoff. Red and blue curves, and image contours represent results from the UNet and simplified architecture, respectively. Error bands in **a** represent the range within a standard deviation of the mean *F*1 across the validation set. **b** Visual comparison of nanoparticle detection, using the Otsu threshold, for the simplified model (blue) and the best performing model (red).

challenges for the use of machine learning in materials science, we find that knowledge of data features and hypothesis-focused model design can still produce accurate and precise results. Moreover, we demonstrate that meaningful features can be learned in a single convolutional layer, allowing us to move closer to a balance between state-of-the-art deep learning methods and physically interpretable results. We evaluate the accuracy of several deep and shallow CNN models and find evidence that, for a relatively simple segmentation task, important image features are learned in the initial convolutional lavers. While we apply common accuracy measures to evaluate our models, we note that other specially designed metrics may help to define exactly where mistakes are made, and thereby which features a model is unable to represent. Whether or not these simplified models reach the accuracy required for quantification of segmented images, a learned indication of important low-level image features can help guide the design of an efficient, parallelizable pipeline for conventional image processing.

We present a method for simultaneously segmenting images and visualizing the features most important for a low-level description of the system. While we don't derive any physical insight from the learned features of our images, this approach could potentially be extended, for example, to a multiclass classification task where learned kernels could elucidate subtle pixel-scale differences between feature classes. For our needs, the interpretability of this basic model helps us to design a segmentation process where measurement accuracy is limited by the resolution of our instrumentation, not by our ability to identify and localize features. Simple segmentation tasks may not fully utilize a deep CNN's ability to recognize very rich, inconspicuous features, but the breadth of literature and open-source tools from the computer science community are available for use in other fields and must be applied in order to determine their limitations. In this regard, we hope to provide a clear description of how architectural features can be tweaked for best performance for the specific challenge of segmenting high-resolution ETEM images.

In all, while computer science research trends toward complicated, yet highly accurate deep learning models, we suggest a data-driven approach, in which deep learning is used to motivate and enhance the application of more straightforward data processing techniques, as a means for producing results that can be clearly interpreted, easily quantified, and reproducible on generalized datasets. In practice, the wide availability of technical literature, programming tools, and step-by-step tutorials simultaneously makes machine learning accessible to a wide audience, while obscuring the fact that application to specific datasets requires an understanding of unique, meaningful data features, and of how models can be harnessed to give usable and meaningful analyses. While common in the field of computer vision, in practice many of the techniques we discuss are added to a machine learning model as a black box, with little understanding of their direct effects on model performance. Framing deep learning challenges in the light of real physical systems, we propose means both for thoughtful model design, and for an application of machine learning where the learned features can be visualized and understood by the user. In this way, analysis of data from high-throughput in situ experiments can become feasible.

METHODS

Sample preparation

An ~1 nm Au film was deposited by electron beam assisted deposition in Kurt J. Lesker PVD 75 vacuum deposition system to form nanoparticles with an approximate diameter of 5 nm. The film was directly deposited onto DENSsolutions Wildfire series chips with SiN support suitable for in situ TEM heating experiments.

TEM imaging

Samples were imaged in an FEI Titan 80–300 S/TEM ETEM operated at 300 kV. Film evolution was studied in vacuum (TEM column base pressure 2×10^{-7} Torr) at 950 °C. High frame rate image capture utilized a Gatan K2-IS direct electron detector camera at 400 frames per second. Selected images (Fig. 1, Supplementary Fig. 1) were acquired on a JEOL F200 S/TEM operated at 200 kV, with images collected on a Gatan OneView camera.

Automated training set generation

Raw ETEM images are processed using a series of Gaussian filters, Sobel filters, morphological opening and closing, and thresholding algorithms to produce pseudo-labeled training images (see provided code for reproducing specifics). All operations are features of the SciKit Image python package³⁹. As a note, we specify that our dataset is pseudo labeled, because we take automatically labeled images as ground truth, while traditionally labeled data is produced manually by experts in the field. Parameters for each of these processing steps, such as the width of the Gaussian filter, are chosen empirically, and the same parameters are applied to all images in the dataset. Depending on the resolution of the image, and the amount of contrast between the nanoparticles and background in the dataset (which determines the number of required processing steps), automated image processing takes between 10 and 30 s per image. Segmentation by this method is faster than manual labeling for particle measurement and localization, which would take hours per image. Training set accuracy is evaluated by overlaying labels on raw images and visually inspecting the difference, as there is no way to quantitatively check the ground truth. Examples of processing steps and training data are shown in Supplemental Fig. 9.

A set of training data was made up of 2400 full ETEM images (1792 imes1920 pixels), collected during a single experiment, downsized via interpolation to a resolution of 512×512 pixels. Additionally, a second training set with 1024×1024 pixel resolution, made by cropping appropriately sized sections from a full 1792 × 1920 image, was created to study the impact of increasing pixel resolution on image segmentation performance. In practice, it is important to consider artifacts introduced by resizing images; stretching or compressing images through interpolation/ extrapolation may change local signal patterns. Cropping sections of images maintains the scale of features in as-collected images, meaning that a model could potentially be trained on many small images (requiring less GPU memory), and then directly evaluated on full images since convolution neural networks do not require specific input/output sizes once training is complete. Augmentation of the dataset was carried out using affine transformations and image rotation, as successive images captured in a short time are not entirely unique/independent.

Programming and training machine learning models

All programming was done in Python, with machine learning aspects using the PyTorch framework⁴⁰. The final dataset consisted of 2400 1024×1024 pixel images, which was randomly split into training (70%, or 1680 images) and validation (30%, or 720 images) sets. In order to avoid inherent bias due to strong correlation between training and test sets in randomly split consecutive images, a third validation set, collected at a different time but under the same conditions, should be included; we neglect to use this

extra dataset, as we only work to show trends in performance as a function of CNN architecture.

In many cases a balanced dataset, where sample sizes of positive and negative examples are roughly equivalent, is required to avoid systematic error and bias while training a CNN. In the images considered here, particle pixels correspond to ~15% of any given image. Though this is quite unbalanced, we find that the general sparsity of features, and the fact that clear edges are the most important factor in identification of nanoparticles in these images, reduce the negative impact of any imbalance.

All CNNs used ReLU activation after each convolutional layer (except where noted later), the Adam optimizer, and cross-entropy loss functions^{41,42}. Since cross-entropy loss in PyTorch includes a final softmax activation, a softmax layer was applied to model outputs for inference. All models were trained for 25 epochs on our System76 Thelio Major workstation using four Nvidia GeForce RTX 2080Ti GPUs, with each model taking 1–2 h to train. We note that longer training periods may be required; we used this time frame to make experimentation with network architecture, data preprocessing, and hyper-parameter tuning more feasible in-house. We gauge that models were stable in this training time by tracking loss as a function of epoch number and seeing general convergence. The binary segmentation map that classifies individual pixels as particle or background was obtained by thresholding predicted softmax output for each pixel.

To obtain quantitative data on the particles themselves, both the training set and CNN segmentation output were processed by a connected components algorithm to produce a labeled image that groups pixels into particle regions from which properties such as size and position can be extracted. This labeling, performed on a binary image, generally takes only one second or less per image

Our base UNet-type architecture for segmenting 512×512 images consisted of three convolutional layers with max-pooling or up-sampling (where applicable) on both downscaling and upscaling sides^{29,43}. The base model for 1024×1024 images adds an additional level of convolutional layers to each side of the model. Adding convolutional layers, as described later to increase segmentation accuracy, refers to adding a successive convolutional layer after each down-/up-sampling level of a UNet-type architecture. Supplementary Fig. 2 shows a representation of the CNN architecture used here.

DATA AVAILABILITY

Contact the corresponding author with requests to view raw data. Sample image sets and all python code used are publicly available in the GitHub repository for this project (link provided below).

CODE AVAILABILITY

Python code for training image generation, UNet training, and evaluation of results are available at https://github.com/jhorwath/CNN_for_TEM_Segmentation.

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AUTHOR CONTRIBUTIONS

E.A.S, D.N.Z., and R.M. conceived of the ideas for data analysis and experimentation. D.N.Z. collected TEM images with minor contributions from J.P.H., and computational experiments and model design were performed by J.P.H. with guidance from R.M. All authors contributed to preparing the final manuscript.

COMPETING INTERESTS

The authors declare no competing interests.

ADDITIONAL INFORMATION

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